	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10787347	KIMURA, HAJIME
	Examiner	Art Unit
	Nguyen, Hiep	2816

														Γ
		ORIGINAL	NAL						INTERNA	TIONAL	CLAS	INTERNATIONAL CLASSIFICATION	Z	
	CLASS			SUBCLASS					CLAIMED	·		NON	NON-CLAIMED	
327			108			I	0	3 K		3 / 00				
		CROSS REFERENCE(S)	RENCE(S)					-						
CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)	NE SUBCLASS	PER BLOCK)				-						
327	109	110	111	112										
326	82	83	28	85	86									
315	169.1	169.2	169.3											
345	204													
			į											
													3	
							$\dashv$	-						
							$\dashv$	$\dashv$						
Hiep Nguyen		03-30-07	\  -	(	, //							Total Clai	Total Claims Allowed:	
(Assistant Examiner)	miner)	(Date) / /	\	)  }	lo Wan								20	
Charle	4 10 3	19/6/	.•	, AUT	TUANT.LAM				11/0	(	0.6	O.G. Print Claim(s)	O.G. Print Figure	<b>-</b> 0
(Legal Instrum	Legal Instruments Examiner)	(Date)	(Primary	'Exam <b>inalyiva</b> H	(Primary Examiner)		0	ate)	> > 1 1	<b>,</b>		1	-	

U.S. Patent and Trademark Office